

## EMI TEST REPORT

### SAMSUNG ELECTRONICS CO., LTD.

Product : **Notebook Computer**  
Model No. : **SENS Pro 750**  
FCC ID : **A3LS750E**  
DATE : **December 10, 1998**

### SAMSUNG Reference NO. : 981223

*This test report is to certify that the tested device properly complies with the requirements of FCC Rules and Regulations Part 15 Subpart B Unintentional Radiators. All tests necessary to show compliance to the requirements were and these results met the specifications requirement.*

**1. Applicant Name** : SAMSUNG ELECTRONICS CO., LTD.  
(Company name & Address) 416 Maetan 3 Dong, Paldal-Ku,  
Suwon City, Kyungki Do, Korea,  
441-742

#### 2. Identification of tested device

2.1 FCC ID : A3LS750E  
2.2 Device Name : Notebook Computer  
2.3 Brand (Trade Name) : SAMSUNG  
2.4 Model Number : SENS Pro 750

#### 3. Test Procedure and Items

3.1 AC Powerline Conducted Emissions Measurement : ANSI C63.4-1992  
3.2 Radiated Emissions Measurement : ANSI C63.4-1992

**4. Issued Date** : December 10, 1998

**TESTED BY :**

*N. G. Park*  
No-Cheon, PARK / Test Engineer

**APPROVED BY :**

*T. J. Shin*  
Taek-Jeong, SHIN / Chief of EMC Lab.

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## 1. General Information

### 1.1 Product Description

The Samsung Electronics Co., Ltd. Notebook Computer Model SENS Pro 750(FCC ID :A3LS750E)is based on the powerful pentium II processor(CPU 366MHz) and has internal clock speeds of 14.318, 33, 48, 56.448 and 66.6MHz. It can be operated from rechargeable battery pack or by 100-240V AC Adapter.

See attached SENS Pro 750 User's Guide for more information.

### 1.2 Grants

The EUT was tested with a External FDD and CD-ROM driver.

Samsung does not intend to market this as a separate unit; therefore, an application for certification is not being filed. This device will be supplied with this computer.

### 1.3 Test System Details

The FCC IDs for all equipment plus descriptions of all cables used with the tested system (including inserted cards which have grant) are:

FCC ID	DESCRIPTION (Model Name)	CABLE DESCRIPTION
A3LS750E	EUT (SENS Pro 750)	-
FCC DOC	External Monitor (6547-3BN)	Shielded interface
EW425-1040D	Serial Mouse (25-1040D)	Unshielded interface
E2XSEM-K15Z	Keyboard (SEM-K15Z)	Unshielded interface
N/A	AC Adaper (AD-5019)	Unshielded interface
N/A	USB Termination cable	Unshielded interface
A3LSMD750E	Mini-Dock(SMD-750EL)	Unshielded interface
DZL210472	PS/2 Mouse (M-S34)	Unshielded interface
C3KMJ1	Joystick (Sidewinder)	Unshielded interface
DSI16XU222	Inkjet Printer (2225C)	Shielded interface
N/A	PCMCIA(SLOTS-2EA)FLASH MEMORY	-
N/A	External FDD (SFD-600E)	Unshielded interface
N/A	Ear-set (-)	Unshielded interface

#### 1.4 Test Methodology

Both radiated and conducted tests were performed according to the procedure in ANSI C63.4-1992. Radiated testing was performed at an antenna-to-EUT distance of three meters.

#### 1.5 Test Facility

All test described in this report were performed by :  
SAMSUNG ELECTRONICS CO., LTD.  
EMC TESTING LABORATORY  
416 Maetan 3 Dong, Paldal-Ku, Suwon City, Kyungki Do, Korea, 441-742  
Open area test site (3 meter) and Shielded Room.

This test facility has been filed in FCC under the criteria in ANSI C63.4-1992.

### 2. SYSTEM TEST CONFIGURATION

#### 2.1 Justification

The system was configured for testing in typical fashion (as a customer would use it), it has internal clock speeds of 14.318, 33, 48, 56.448 and 66.6MHz. The EUT was investigated while operating at all speeds. The highest speed of 366MHz CPU was used for final testing as it was found to cause worst case emissions.

The EUT's video circuitry is capable of operating at a maximum non-interlaced resolution of 800x600 pixels. The EUT was observed while scrolling a continuous stream for capital "H's" in the 800x600 mode(both LCD 12.1" and External Monitor).

Comparing the test results with Mini-Dock and without Mini-Dock. The test result with Mini-Dock was found the worst case emissions. And so the final testing was performed with Mini-Dock. Samsung does intend to market this Mini-Dock as a separate unit. Therefore this Mini-Dock will not be supplied with the EUT.

Also, comparing the test results with Ext. CD-ROM driver and with Ext. FDD, the test result with Ext. CD-ROM driver was found the worst case emissions. And so the final testing was performed with Ext. CD-ROM driver.

The External FDD and CD-ROM driver that was tested with the computer is intended to be sold with the computer. It will not be marketed as a separate unit.

The EUT was tested with a Samsung AC Adapter Model number AD-5019. Further details of cabling and configuration are shown in the test system configuration.

## 2.2 Video Mode Justification

The system was tested in 800x600 highest resolution mode.  
Since the 800x600 resolution mode(LCD & External Monitor both in use)  
was found to be worst case, this mode was used to collect the included data.

## 2.3 EUT Exercise Software

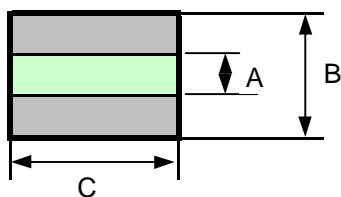
The EUT exercise program used during testing was designed to exercise the system in a manner similar to a typical use. This program was contained on the EUT's Hard Disk and CD-ROM Drv. Once loaded, the program sequentially exercise each system component in turn. The sequence used was : 1) serial "H"s scrolled to the LCD and Monitor; 2) copy series of "H"s characters to mass storage device.

3) print series of H characters to printer. Since the mouse and speaker are strictly input device, no data was transmitted to them during testing. They are, however, continuously scanned for data input activity.

## 2.4 Special Accessories

The Samsung AC adapter and Floppy disk drive connect cable has a ferrite bead on the line as supplied by the manufacturer.

The ferrite specification that used on AC adapter and floppy disk drive connection cable. The following is ferrite specification.



### AC Adapter

A : 4.7mm

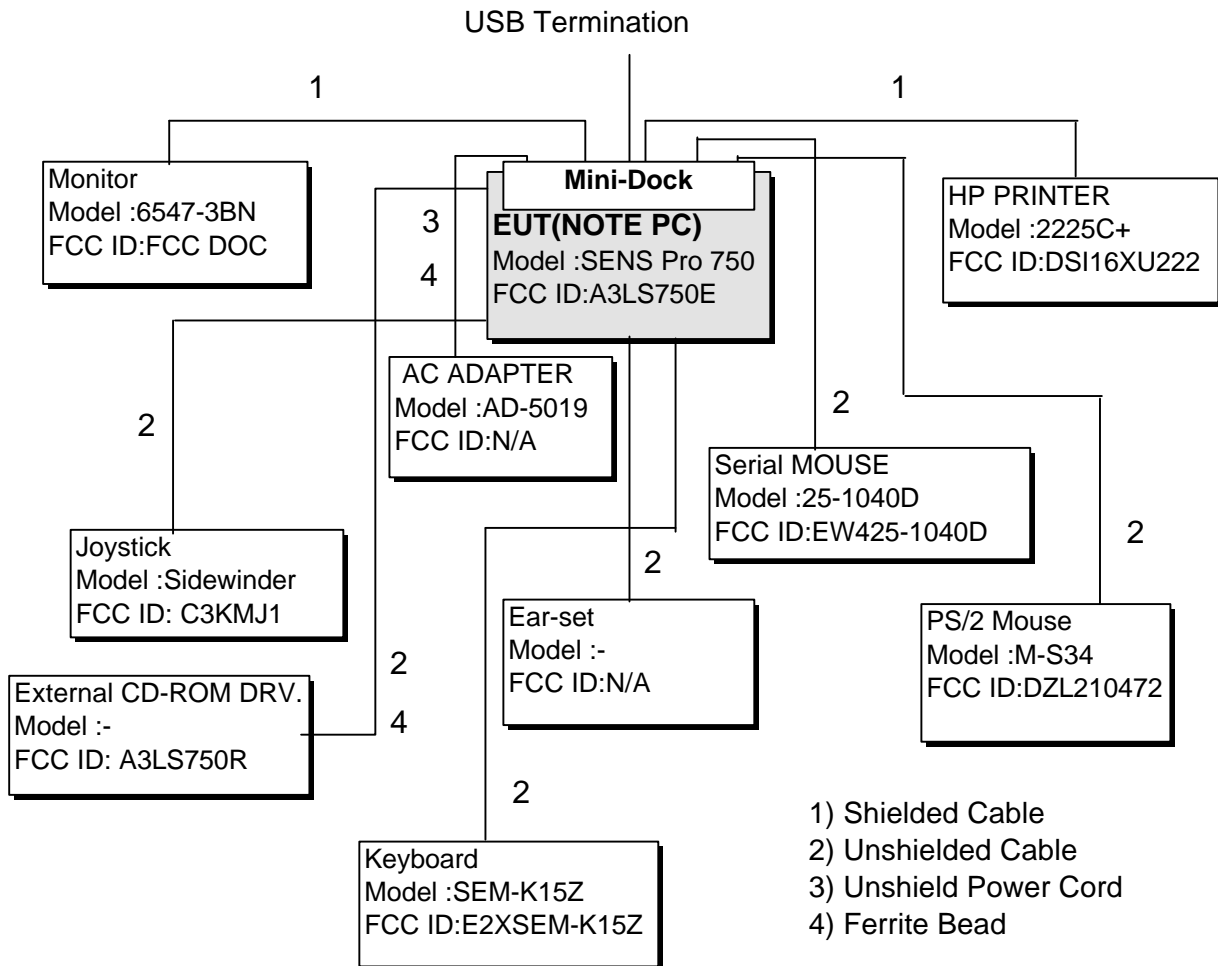
B : 9.8mm

C :24.5mm

## 2.5 Equipment Modifications

No equipment modifications were performed during testing.

### 2.6 Test System configuration

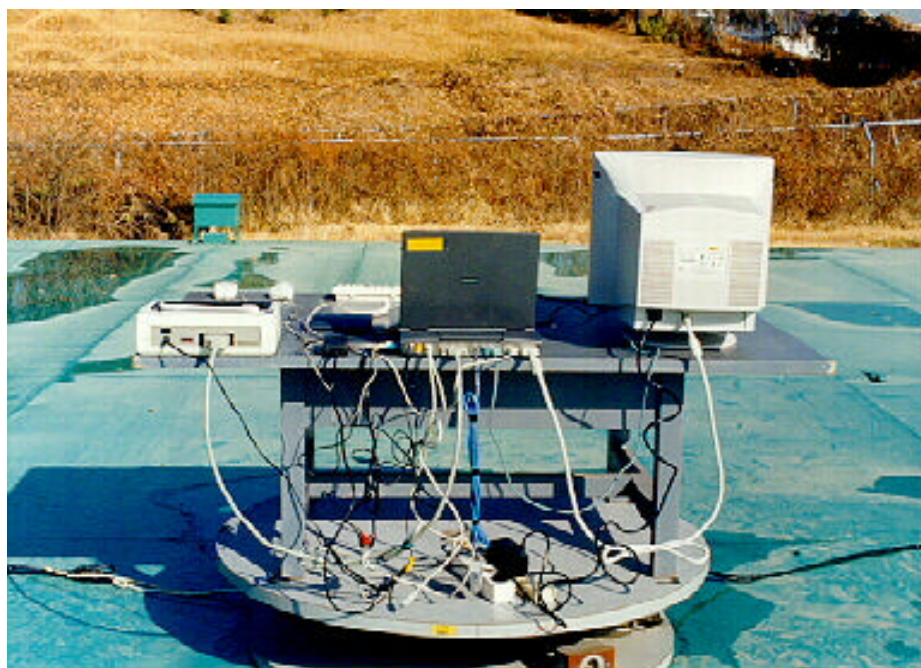


## 2.7 Photographs

### ***Radiation(Front View)***



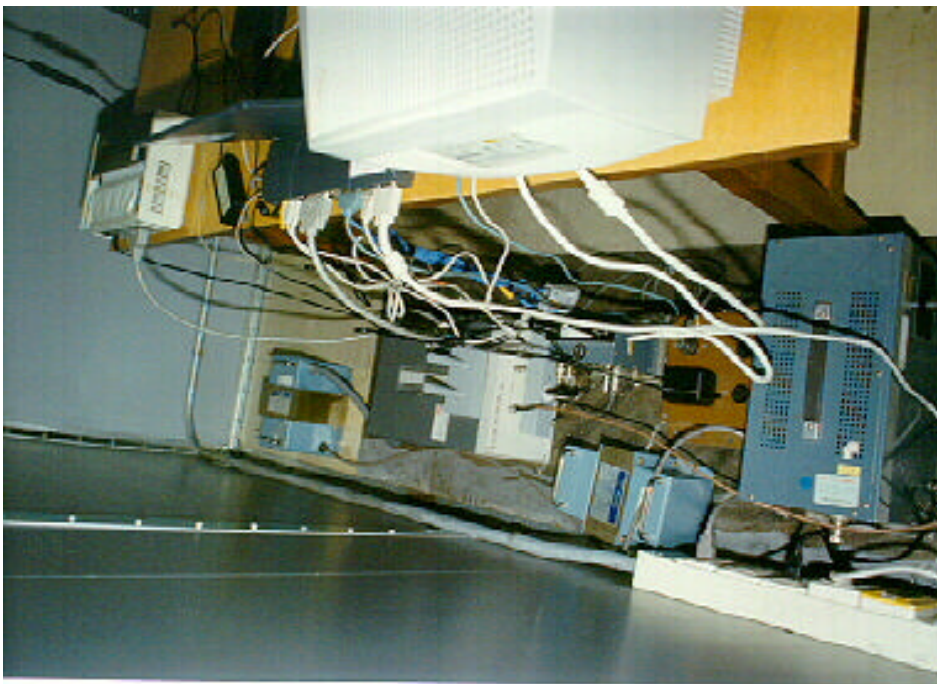
### ***Radiation(Rear View)***



**Conduction(Front View)**



**Conduction(Side View)**



### 3. CONDUCTED EMISSION DATA

The initial step in collecting conducted data was to perform a quasi-peak scan over the measurement range using a spectrum analyzer.

#### Sample Calculation

Frequency : 0.538 [MHz]  
 Meter Reading : 39.7 [dBuV]  
 Factor of LISN : 0.1 [dB]

Then, Result is calculated as follows.

$$39.7 + 0.1 = 39.8 \text{ [dBuV]}$$

#### Test Data Sheet

Tested Frequency [MHz]	Meter Reading (Quasi-Peak) [A] [dBuV]	LISN Pol. [L1,L2]	Total Loss [B] [dB]	Results [A+B] [dBuV]	Limits [dBuV]	FCC Margin [dB]
0.538	39.7	L1	0.1	<b>39.8</b>	48	8.2
0.734	39.8	L2	0.1	<b>39.9</b>	48	8.1
0.932	39.3	L1	0.1	<b>39.4</b>	48	8.6
1.133	38.5	L1	0.1	<b>38.6</b>	48	9.4
1.331	37.4	L1	0.1	<b>37.5</b>	48	10.5
16.245	35.4	L1	0.1	<b>35.5</b>	48	12.5

#### 4. RADIATED EMISSION DATA

The initial step in collecting radiated data was to perform a quasi-peak scan over the measurement range using a spectrum analyzer. All modes of operation were investigated and the worst-case emission are reported. All other emission are non-significant.

##### Sample Calculation

Frequency : 30.5 [MHz]  
 Meter Reading : 18.3 [dBuV]  
 Total of Loss : 15.52 [dB]

Then, Result is calculated as follows.

$$18.3 + 15.52 = 33.82 \text{ [dBuV]}$$

##### Test Data Sheet

Frequency Range [MHz]	Tested Frequency [MHz]	ANT Pol.	Meter Reading [A] [dBuV/m]	Total Loss [B] [dB]	Results [A+B] [dBuV/m]	FCC Margin [dB]	Limits [3m] [dBuV/m]
<b>30 - 88</b>	30.5	V	18.3	15.52	33.82	6.18	<b>40.0</b>
	33.2	V	22.2	13.9	36.1	3.9	
	40.8	V	21.9	12.28	34.18	5.82	
	66.7	H	24.1	9.13	33.23	6.77	
	80.2	V	20.0	9.32	29.32	10.68	
	86.2	V	23.3	9.93	33.23	6.77	
<b>88 - 216</b>	92.6	H	20.4	10.53	30.93	12.57	<b>43.5</b>
	96.4	V	22.2	11.03	33.23	10.27	
	100.5	V	22.8	11.53	34.33	9.17	
	110.2	V	19.7	12.38	32.08	11.42	
	120.2	V	18.1	13	31.1	12.4	
	185	V	18.7	15.35	34.05	9.45	
<b>216 - 960</b>	238.7	H	20.0	18.47	38.47	7.53	<b>46.0</b>
	259	V	16.7	19.11	35.81	10.19	
	267.1	V	15.9	19.25	35.15	10.85	
	300	H	17.1	22.13	39.23	6.77	
	319.6	H	14.1	16.28	30.38	15.62	
	558.3	V	23.1	20.23	43.33	2.67	
<b>960 -</b>	961.5	H	<6	31.4	-	-	<b>54.0</b>
	1212	H	<6	31.5	-	-	
	1675	H	<6	36.4	-	-	

[NOTE] "<" Means equal or less than

Receiving Antenna polarization : **Horizontal, Vertical**

5. LIST OF TEST INSTRUMENT.

Equipment	Model No.	Serial No.	Makers	Calibration Last calibration and Interval
Spectrum analyzer	8566B	2611A02672	H.P	98/ 9/21, 12Months
Quasi-peak adapter	85650A	2521A00687	H.P	98/ 9/21, 12Months
RF Preselector	85685A	2602A00224	H.P	98/ 9/21, 12Months
Field strength meter	ESS	844861/005	R & S	98/ 3/16, 12Months
	ESVP	860688/015	R & S	98/ 9/21, 12Months
L.I.S.N	3825-2	9208-1981	EMCO	98/ 9/ 5, 12Months
Double Ridged WaveGuide	3115	4028	EMCO	98/10/ 2, 12Months
Bi-conical Antenna	3110B	2012	EMCO	98/12/ 1, 12Months
Log-periodic Antenna	3146A	1320	EMCO	98/12/ 1, 12Months